

1. General description

Planar passivated high commutation three quadrant triac in a TO252 (DPAK) surface mountable plastic package intended for use in circuits where high static and dynamic dV/dt and high dI/dt can occur. This triac will commute the full RMS current at the maximum rated junction temperature ($T_{j(max)} = 150\text{ °C}$) without the aid of a snubber. It is used in applications where "high junction operating temperature capability" is required.

2. Features and benefits

- 3Q technology for improved noise immunity
- High commutation capability with maximum false trigger immunity
- High immunity to false turn-on by dV/dt
- High junction operating temperature capability
- High voltage capability
- Less sensitive gate for very high noise immunity
- Planar passivated for voltage ruggedness and reliability
- Surface mountable package
- Triggering in three quadrants only

3. Applications

- Applications subject to high temperature
- Electronic thermostats (heating and cooling)
- High power motor controls e.g. washing machines and vacuum cleaners
- Rectifier-fed DC inductive loads e.g. DC motors and solenoids

4. Quick reference data

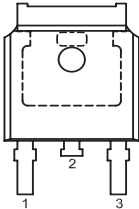
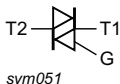
Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes	Values	Unit
V_{DRM}	repetitive peak off-state voltage			800	V
$I_{T(RMS)}$	RMS on-state current	full sine wave; $T_{mb} \leq 126\text{ °C}$; Fig. 1 ; Fig. 2 ; Fig. 3		16	A
I_{TSM}	non-repetitive peak on-state current	full sine wave; $T_{j(init)} = 25\text{ °C}$; $t_p = 20\text{ ms}$; Fig. 4 ; Fig. 5		140	A
		full sine wave; $T_{j(init)} = 25\text{ °C}$; $t_p = 16.7\text{ ms}$		154	A
T_j	junction temperature			-40 to 150	°C

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
Static characteristics							
I_{GT}	gate trigger current	$V_D = 12\text{ V}$; $I_T = 100\text{ mA}$; T2+ G+; $T_J = 25\text{ °C}$; Fig. 7		5	-	35	mA
		$V_D = 12\text{ V}$; $I_T = 100\text{ mA}$; T2+ G-; $T_J = 25\text{ °C}$; Fig. 7		5	-	35	mA
		$V_D = 12\text{ V}$; $I_T = 100\text{ mA}$; T2- G-; $T_J = 25\text{ °C}$; Fig. 7		5	-	35	mA
I_H	holding current	$V_D = 12\text{ V}$; $T_J = 25\text{ °C}$; Fig. 9		-	-	30	mA
V_T	on-state voltage	$I_T = 16\text{ A}$; $T_J = 25\text{ °C}$; Fig. 10		-	-	1.5	V
Dynamic characteristics							
dV_D/dt	rate of rise of off-state voltage	$V_{DM} = 536\text{ V}$; $T_J = 150\text{ °C}$; exponential waveform; gate open circuit		2000	-	-	V/ μ s
dI_{com}/dt	rate of change of commutating current	$V_D = 400\text{ V}$; $T_J = 150\text{ °C}$; $I_{T(RMS)} = 16\text{ A}$; $dV_{com}/dt = 20\text{ V}/\mu\text{s}$; gate open circuit; snubberless condition		12	-	-	A/ms

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	T1	main terminal 1		 sym051
2	T2	main terminal 2		
3	G	gate		
mb	T2	mounting base; main terminal 2		

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
BTA316S-800CT	TO252	BTA316S-800CTJ	Reel	2500	TO252N	04-Nov-2016

7. Marking

Table 4. Marking codes

Type number	Marking codes
BTA316S-800CT	BTA316S 800CT

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
V_{DRM}	repetitive peak off-state voltage			800	V
$I_{T(RMS)}$	RMS on-state current	full sine wave; $T_{mb} \leq 126\text{ °C}$; Fig. 1 ; Fig. 2 ; Fig. 3		16	A
I_{TSM}	non-repetitive peak on-state current	full sine wave; $T_{j(initial)} = 25\text{ °C}$; $t_p = 20\text{ ms}$; Fig 4 ; Fig 5		140	A
		full sine wave; $T_{j(initial)} = 25\text{ °C}$; $t_p = 16.7\text{ ms}$		154	A
I^2t	I^2t for fusing	$t_p = 10\text{ ms}$; sine-wave pulse		98	A^2s
di_T/dt	rate of rise of on-state current	$I_G = 70\text{ mA}$		100	$A/\mu s$
I_{GM}	peak gate current	$t_p = 20\text{ }\mu s$		2	A
P_{GM}	peak gate power			5	W
$P_{G(AV)}$	average gate power	over any 20 ms period		0.5	W
T_{stg}	storage temperature			-40 to 150	$^{\circ}C$
T_j	junction temperature			-40 to 150	$^{\circ}C$

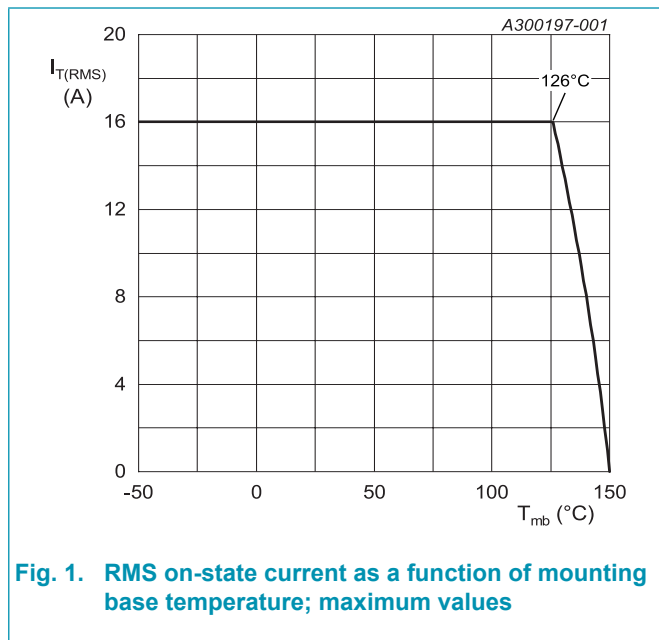


Fig. 1. RMS on-state current as a function of mounting base temperature; maximum values

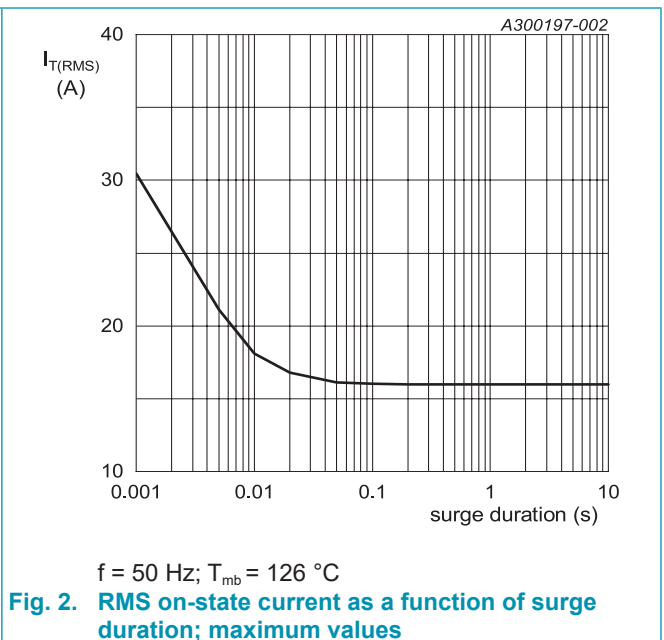
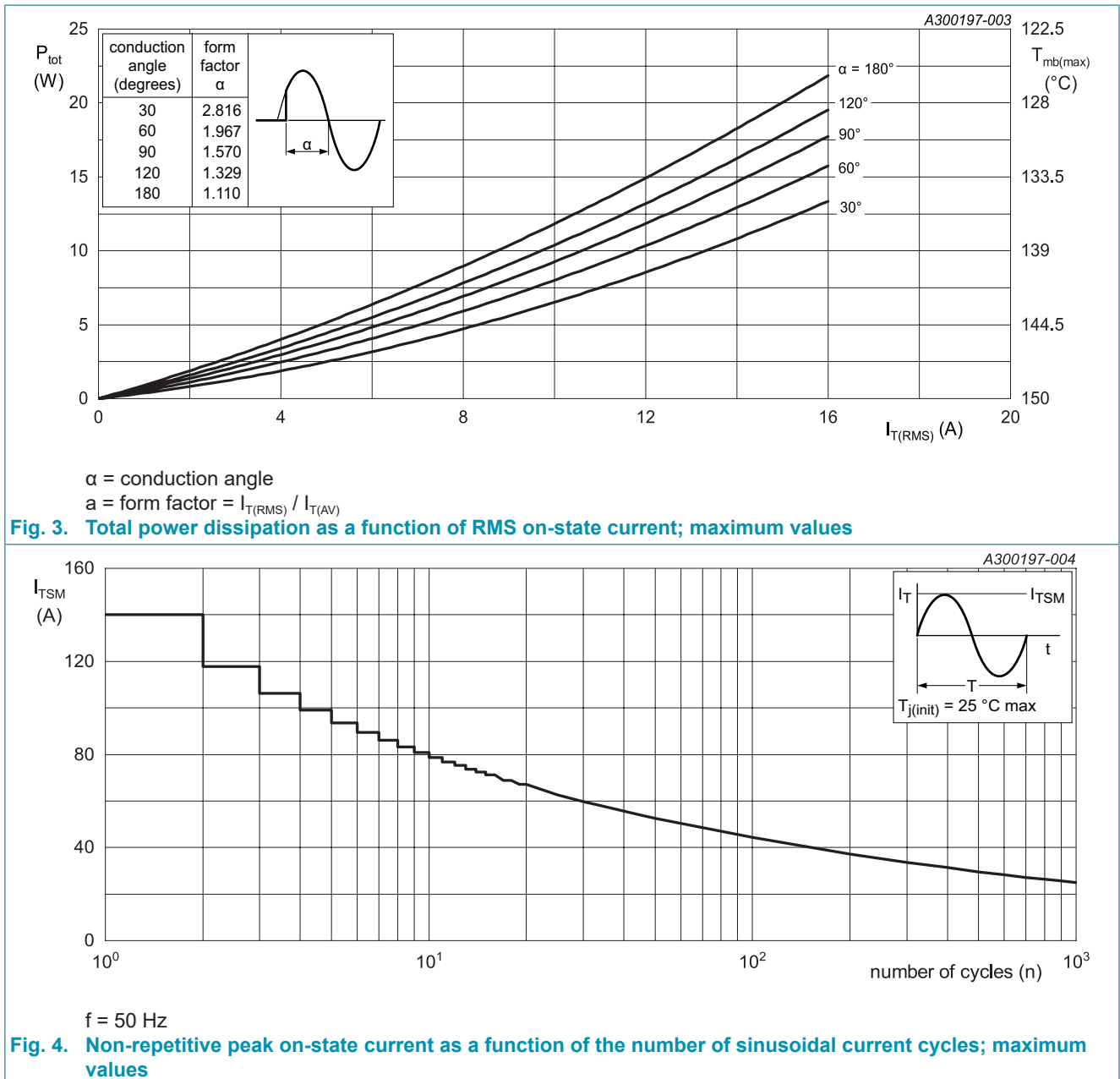
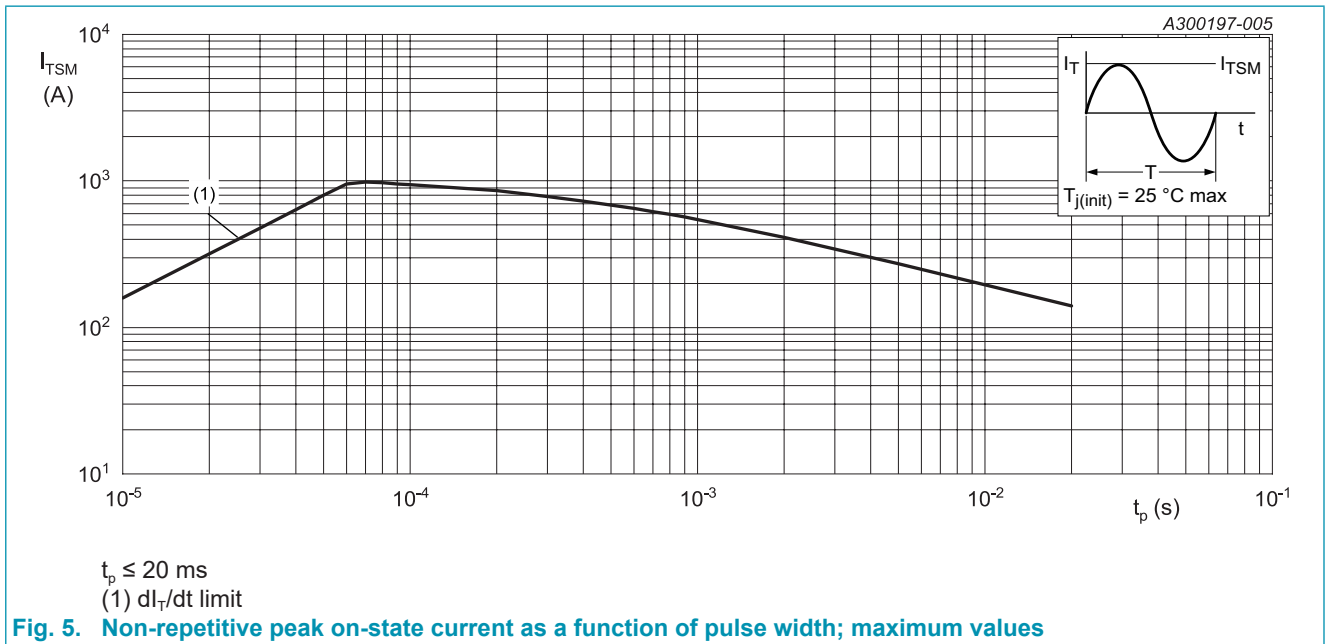


Fig. 2. RMS on-state current as a function of surge duration; maximum values
 $f = 50\text{ Hz}$; $T_{mb} = 126\text{ }^{\circ}C$





9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	full cycle; Fig. 6		-	-	1.1	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air; printed circuit board (FR4) mounted		-	50	-	K/W

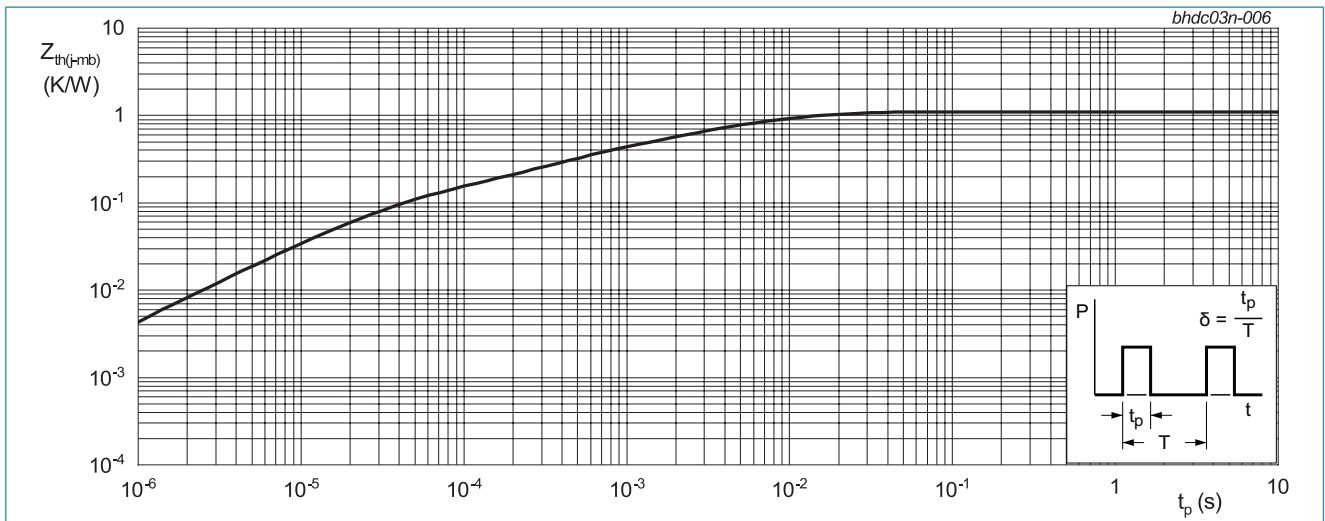
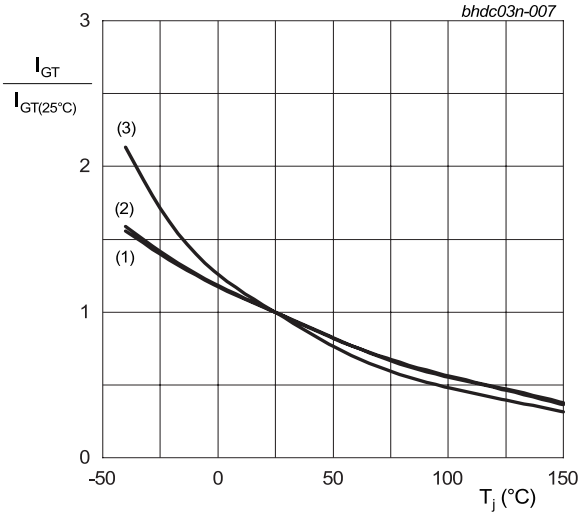


Fig. 6. Transient thermal impedance from junction to mounting base as a function of pulse width

10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
Static characteristics							
I_{GT}	gate trigger current	$V_D = 12\text{ V}$; $I_T = 100\text{ mA}$; T2+ G+; $T_J = 25\text{ °C}$; Fig. 7		5	-	35	mA
		$V_D = 12\text{ V}$; $I_T = 100\text{ mA}$; T2+ G-; $T_J = 25\text{ °C}$; Fig. 7		5	-	35	mA
		$V_D = 12\text{ V}$; $I_T = 100\text{ mA}$; T2- G-; $T_J = 25\text{ °C}$; Fig. 7		5	-	35	mA
I_L	latching current	$V_D = 12\text{ V}$; $I_G = 100\text{ mA}$; T2+ G+; $T_J = 25\text{ °C}$; Fig. 8		-	-	40	mA
		$V_D = 12\text{ V}$; $I_G = 100\text{ mA}$; T2+ G-; $T_J = 25\text{ °C}$; Fig. 8		-	-	60	mA
		$V_D = 12\text{ V}$; $I_G = 100\text{ mA}$; T2- G-; $T_J = 25\text{ °C}$; Fig. 8		-	-	40	mA
I_H	holding current	$V_D = 12\text{ V}$; $T_J = 25\text{ °C}$; Fig. 9		-	-	30	mA
V_T	on-state voltage	$I_T = 16\text{ A}$; $T_J = 25\text{ °C}$; Fig. 10		-	-	1.5	V
V_{GT}	gate trigger voltage	$V_D = 12\text{ V}$; $I_T = 100\text{ mA}$; $T_J = 25\text{ °C}$; Fig. 11		-	0.75	1	V
		$V_D = 400\text{ V}$; $I_T = 100\text{ mA}$; $T_J = 150\text{ °C}$		0.2	0.45	-	V
I_D	off-state current	$V_D = 800\text{ V}$; $T_J = 25\text{ °C}$		-	-	1	μA
		$V_D = 800\text{ V}$; $T_J = 150\text{ °C}$		-	-	1	mA
I_R	reverse current	$V_R = 800\text{ V}$; $T_J = 25\text{ °C}$		-	-	1	μA
		$V_R = 800\text{ V}$; $T_J = 150\text{ °C}$		-	-	1	mA
Dynamic characteristics							
dV_D/dt	rate of rise of off-state voltage	$V_{DM} = 536\text{ V}$; $T_J = 150\text{ °C}$; ($V_{DM} = 67\%$ of V_{DRM}); exponential waveform; gate open circuit		2000	-	-	V/ μs
dI_{com}/dt	rate of change of commutating current	$V_D = 400\text{ V}$; $T_J = 150\text{ °C}$; $I_{T(RMS)} = 16\text{ A}$; $dV_{com}/dt = 20\text{ V}/\mu\text{s}$; gate open circuit; snubberless condition		12	-	-	A/ms



- (1) T2+ G-
- (2) T2+ G+
- (3) T2- G-

Fig. 7. Normalized gate trigger current as a function of junction temperature

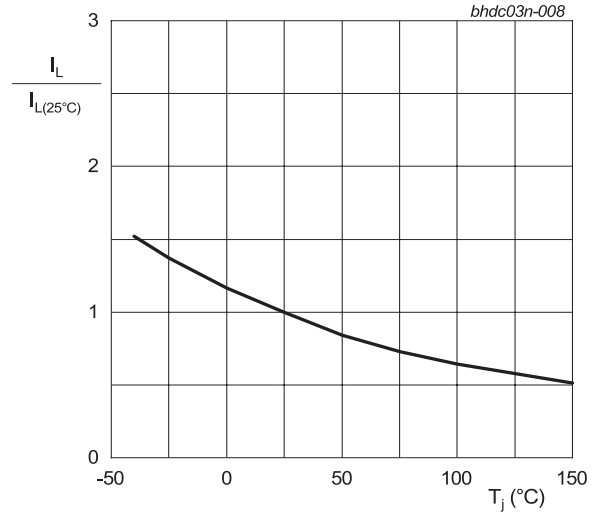


Fig. 8. Normalized latching current as a function of junction temperature

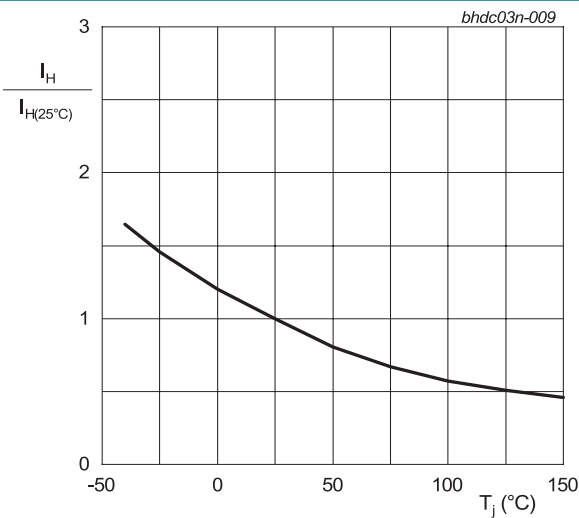
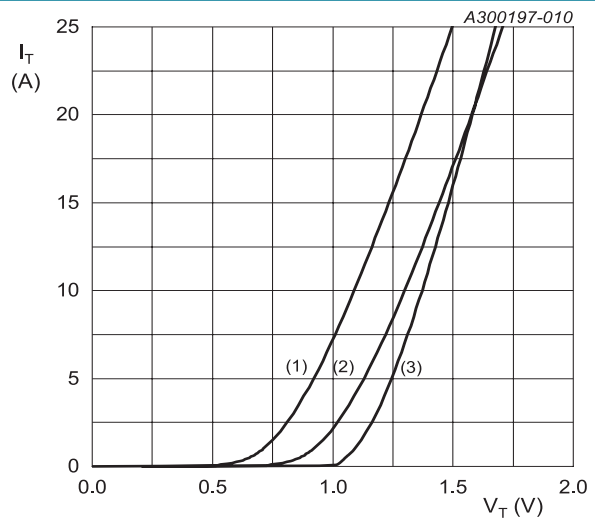


Fig. 9. Normalized holding current as a function of junction temperature



- $V_o = 0.974 \text{ V}; R_s = 0.0305 \text{ } \Omega$
- (1) $T_j = 150 \text{ } ^\circ\text{C}$; typical values
 - (2) $T_j = 150 \text{ } ^\circ\text{C}$; maximum values
 - (3) $T_j = 25 \text{ } ^\circ\text{C}$; maximum values

Fig. 10. On-state current as a function of on-state voltage

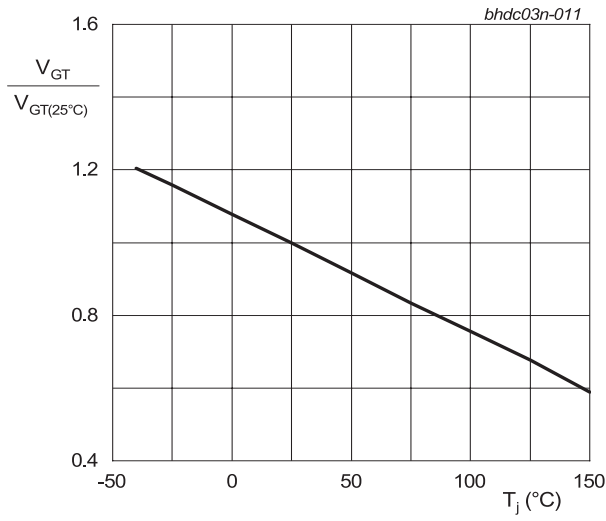
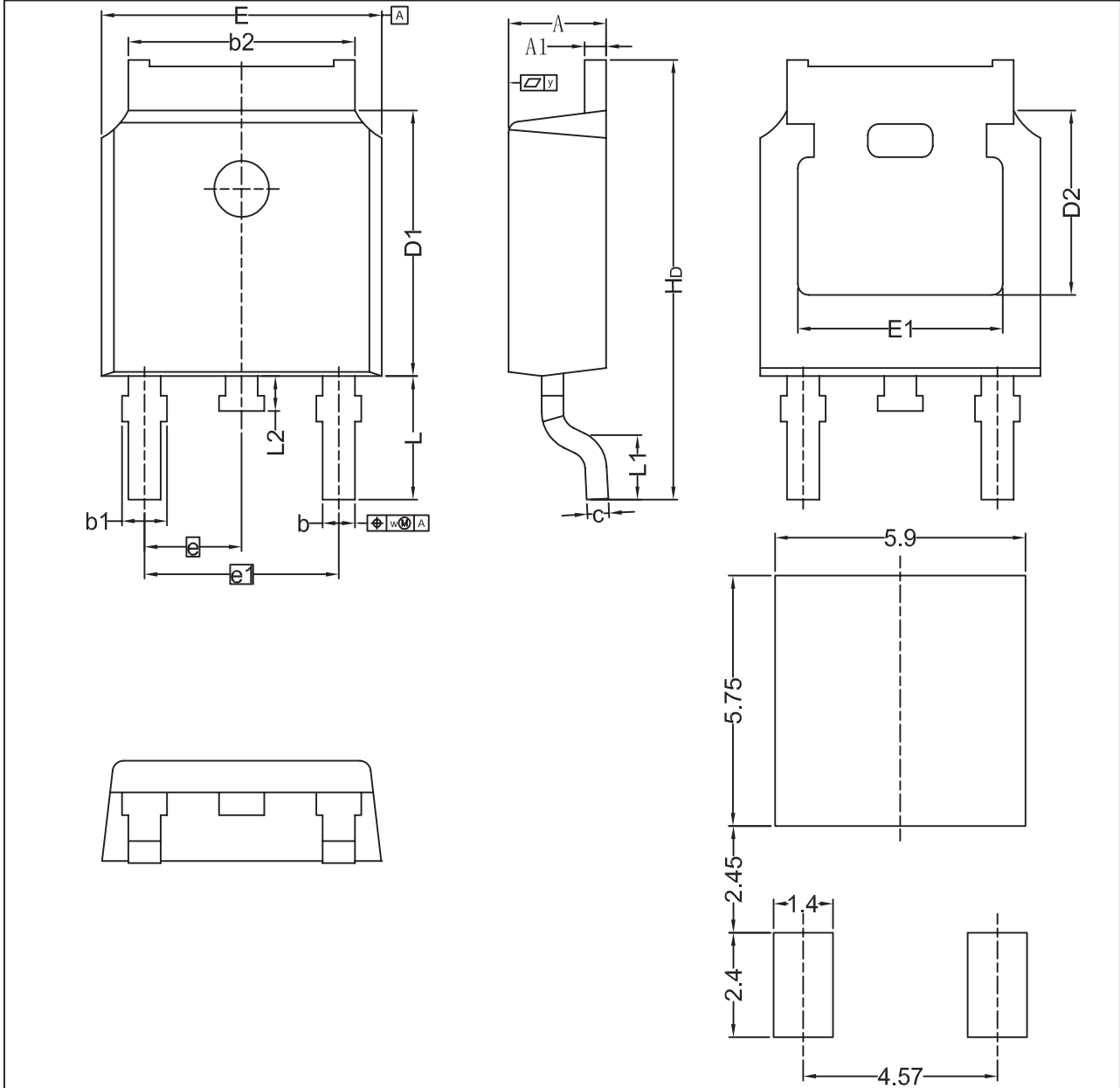


Fig. 11. Normalized gate trigger voltage as a function of junction temperature

11. Package outline

Plastic single-ended surface-mounted package (DPAK); 3 leads (one lead cropped)

TO252



Recommended Footprint

Unit	A	A1	b	b1	b2	c	D1	D2	E	E1	e	e1	H _D	L	L1	L2	w	y
min	2.22	0.46	0.71	0.72	5.00	0.20	5.98	4.00	6.47	4.45	2.285	4.57	9.60	2.90	0.50	0.50	0.20	
mm nom														(Ref.)				
max	2.38	0.93	0.89	1.10	5.46	0.56	6.22	---	6.73	---			10.40	---	0.90		0.20	0.20

12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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